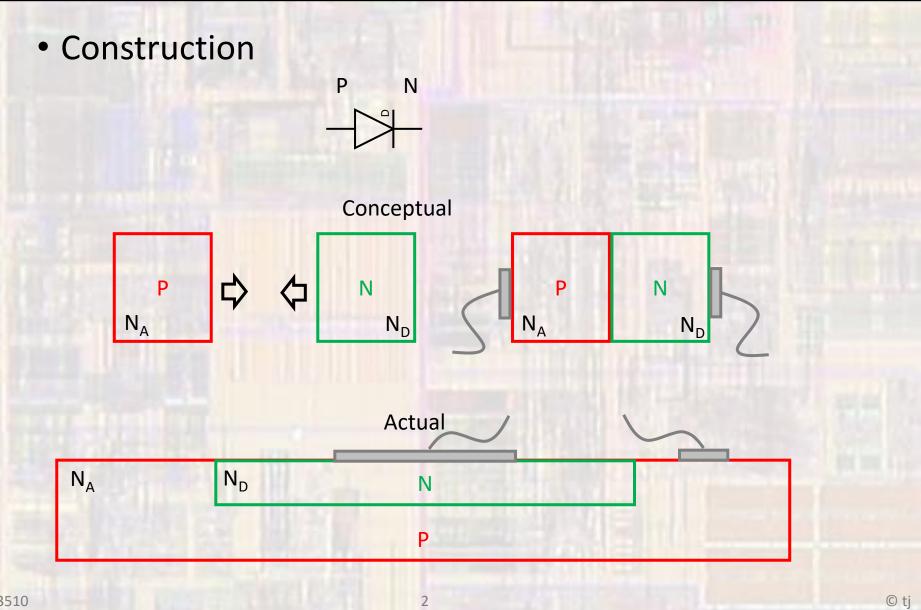
# Last updated 7/1/23

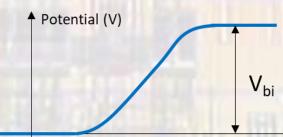
These concepts have been greatly simplified



Carrier Concentrations – built-in Potential

Electric Potential: Amount of work needed to move a unit charge from a reference point to a specific point against an electric field

Required voltage to get current to flow from  $P \rightarrow N$ 



$$V_{bi} = \frac{kT}{q} ln\left(\frac{N_A N_D}{n_i^2}\right)$$

$$V_{bi} = V_T ln\left(\frac{N_A N_D}{n_i^2}\right)$$

$$V_T = \frac{kT}{q} = 26mV \ @RT$$

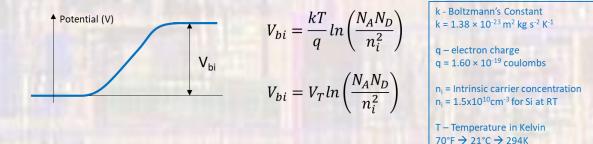
k - Boltzmann's Constant k =  $1.38 \times 10^{-23} \text{ m}^2 \text{ kg s}^{-2} \text{ K}^{-1}$ 

q - electron charge $q = 1.60 \times 10^{-19} coulombs$ 

 $n_i$  = Intrinsic carrier concentration  $n_i$  = 1.5x10<sup>10</sup> cm<sup>-3</sup> for Si at RT

T − Temperature in Kelvin 70°F  $\rightarrow$  21°C  $\rightarrow$  294K Typically call Room Temp (RT) 300K

Carrier Concentrations – built-in Potential



Si diode @RT with  $N_A = 10^{17}$ ,  $N_D = 10^{16}$ 

Typically call Room Temp (RT) 300K

© tj

$$V_{bi} = \frac{1.38 \times 10^{-23} \text{ m}^2 \text{ kg s}^{-2} \text{ K}^{-1} \times 300 \text{K}}{1.60 \times 10^{-19} \text{ coulombs}} \ln\left(\frac{10^{17} \text{ cm}^{-3} \times 10^{16} \text{ cm}^{-3}}{(1.5 \times 10^{10} \text{ cm}^{-3})^2}\right)$$

 $V_{bi} = 753mV$ 

Note: @RT,  $V_T = \frac{kT}{q} = 25.9 \text{mV} \approx 26 \text{mV}$ this is a common simplification  $V_{bi} = 757 \text{mV}$ 

Ideal Diode Equation

n

I<sub>S</sub>

# $I_D = I_S \left[ e^{\left(\frac{qV_A}{nkT}\right)} - 1 \right] = I_S \left[ e^{\left(\frac{V_A}{nV_T}\right)} - 1 \right]$

VA

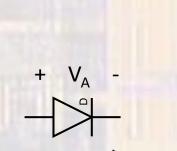
Accounts for non-idealities Typically, between 1 and 2

> proportional to Area (A) Inversely proportional to Doping  $(n_{po}, p_{no})$ Typically,  $10^{-12}A - 10^{-18}A$

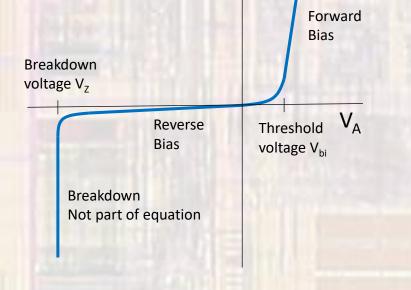
n

• Real diode behavior

$$I_D = I_S \left[ e^{\left(\frac{qV_A}{nkT}\right)} - 1 \right] = I_S \left[ e^{\left(\frac{V_A}{nV_T}\right)} - 1 \right]$$

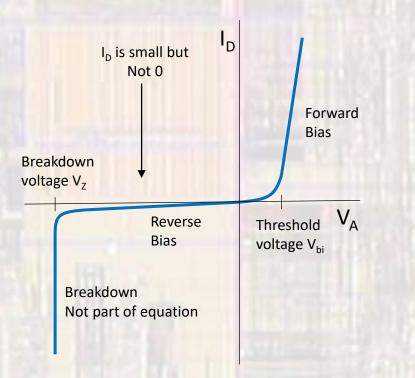


 $I_{D}$ 

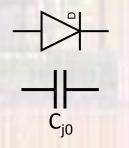


I<sub>D</sub>

- Reverse bias leakage current
  - For negative biases the current is NOT 0
  - This will impact our digital circuit power consumption



• Carrier Concentrations – junction capacitance



- The depletion region (area near the junction) acts like an insulator
  - No mobile charge
  - At 0V external bias the capacitance is C<sub>i0</sub>
- This will limit the speed of our digital systems